



Contribution ID: 249

Type: **Invited Speaker / Conférencier invité**

## Terahertz-frequency test for Fermi liquid conductivity in MnSi

*Tuesday 17 June 2014 08:45 (30 minutes)*

Fermi liquid theory predicts that electron-electron scattering will contribute  $\rho_{e-e}(\omega, T) = A [(\hbar\omega)^2 + b(\pi k_B T)^2]$  to the frequency-dependent resistivity of any metal at low temperatures and frequencies. In its simplest form, the theory further predicts that the temperature and frequency dependence are related by  $b = 4$ , but numerous experimental studies have yielded  $b \approx 1$  for different metals, and none have observed the predicted value. I will review progress in understanding this issue, with an emphasis on our measurements on MnSi with terahertz time-domain spectroscopy. As with other metals, the resistivity exhibits the quadratic frequency dependence predicted by Fermi liquid theory, but with  $b \approx 1$  over a wide range in temperature. At the lowest temperatures, we observe evidence for a crossover to  $b \approx 4$ , although this is currently limited by a large systematic uncertainty that we will discuss. Additionally, we have determined the Drude scattering rate and plasma frequency at low temperatures, and compared these to realistic band theory calculations. Above a coherence temperature  $T_{coh} \approx 50$  K, we find evidence for the existence of a pseudogap. Below  $T_{coh}$ ,  $\tau$  increases dramatically to  $\tau \approx 0.5$  ps at  $T \approx 5$  K. From a comparison of the low-temperature plasma frequency measurement with band theory, we determine a mass renormalization of  $m^*/m \approx 5.5$ , which compares favorably with earlier quantum oscillation measurements.

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**Session Classification:** (T1-7) Quantum Materials - DCMMP / Matériaux quantiques - DPMCM

**Track Classification:** Condensed Matter and Materials Physics / Physique de la matière condensée et matériaux (DCMMP-DPMCM)